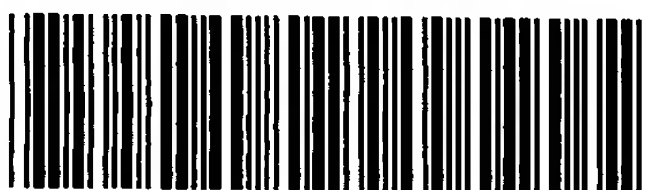


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/648,945	BAZAN ET AL.	
	Examiner	Art Unit	
	Jezia Riley	1637	

SEARCHED			
Class	Subclass	Date	Examiner
435	6		
536	22.1,23.1		
536	24.3,26.6	4/30/2007	JR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
435	6	//	//
536	22.1,23.1	//	//
536	24.3,26.6	4/30/2007	JR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR